

<b>Notice of References Cited</b>			Application/Control No. 10/535,579	Applicant(s)/Patent Under Reexamination DOBASHI ET AL.	
			Examiner Martin J. Angebranndt	Art Unit 1795	Page 1 of 1

**U.S. PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-6,811,728 B2	11-2004	Yagi et al.	264/1.24
*	B	US-6,729,541 B1	05-2004	Kurokawa et al.	235/454
*	C	US-3,635,538	01-1972	Caulfield et al.	359/7
*	D	US-5,529,861 A	06-1996	Redfield, Stephen R.	430/1
*	E	US-2004/0194151 A1	09-2004	Earhart, Tod	725/135
*	F	US-2005/0028186 A1	02-2005	Hertrich, Gregory P.	720/738
*	G	US-6,674,556 B1	01-2004	Mori et al.	359/32
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

**FOREIGN PATENT DOCUMENTS**

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N	03/044574	05-2003	WIPO	Goulianian et al.	***
	O					
	P					
	Q					
	R					
	S					
	T					

**NON-PATENT DOCUMENTS**

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
*	U	translation of JP 2003-141475
*	V	translation of JP 63-022617
*	W	Translation of JP 2001-265197
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a))  
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